

Title (en)

SUBMICRON RESOLUTION SPECTRAL-DOMAIN OPTICAL COHERENCE TOMOGRAPHY

Title (de)

OPTISCHE SPEKTRAL-DOMÄNEN-KOHÄRENZTOMOGRAFIE MIT SUBMIKRONENAUFLÖSUNG

Title (fr)

TOMOGRAPHIE À COHÉRENCE OPTIQUE DANS LE DOMAINE SPECTRAL À RÉSOLUTION SUBMICRONIQUE

Publication

**EP 2847572 A4 20160113 (EN)**

Application

**EP 13788380 A 20130508**

Priority

- US 201261644240 P 20120508
- US 2013040185 W 20130508

Abstract (en)

[origin: US2013301033A1] Apparatuses and systems for submicron resolution spectral-domain optical coherence tomography (OCT) are disclosed. The system may use white light sources having wavelengths within 400-1000 nanometers, and achieve resolution below 1 mum. The apparatus is aggregated into a unitary piece, and a user can connect the apparatus to a user provided controller and/or light source. The light source may be a supercontinuum source.

IPC 8 full level

**G01B 9/02** (2006.01); **G01N 21/00** (2006.01); **G01N 21/62** (2006.01)

CPC (source: EP US)

**G01B 9/02044** (2013.01 - EP US); **G01B 9/02051** (2013.01 - EP US); **G01B 9/02091** (2013.01 - EP US); **G01J 3/45** (2013.01 - US)

Citation (search report)

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- [A] GUNAY YURTSEVER ET AL: "Towards Integrated Optical Coherence Tomography System on Silicon on Insulator", PROCEEDINGS 2008; THIRTEENTH ANNUAL SYMPOSIUM OF THE IEEE/LEOS BENELUX CHAPTER; UNIVERSITY OF TWENTE, THE NETHERLANDS; NOVEMBER 27-28, 2008, , 27 November 2008 (2008-11-27), pages 163 - 166, XP002733484
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- See references of WO 2013169934A1

Designated contracting state (EPC)

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DOCDB simple family (publication)

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DOCDB simple family (application)

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